## IAPZORec'd PCT/PTO 08 JUN 2008T

### IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

#### EXPRESS MAIL NO. EV809338424US

**Applicant** 

: Shinichi Okawa, et al.

Application No. : N/A

Filed

11

: June 8, 2006

Title

: DENTAL DIAGNOSTIC AND TREATMENT APPARATUS (AS

AMENDED)

Grp./Div.

: N/A

Examiner

: N/A

Docket No.

: 57800/A400

### INFORMATION DISCLOSURE STATEMENT 37 CFR § 1.97(b)

Commissioner for Patents

Post Office Box 7068

P.O. Box 1450-

Pasadena, CA 91109-7068

Alexandria, VA 22313-1450

June 8, 2006

### Commissioner:

In compliance with the duty of disclosure under 37 CFR §§ 1.56, 1.97 and 1.98, and in accordance with the provisions in the Manual of Patent Examining Procedure §§ 609 and 707.05(b), enclosed is FORM PTO/SB/08A/B listing the references that are known to applicant. Copies of the references listed as "ON ORDER" will be provided upon receipt of the same. This filing is timely because it is made during one of the periods described in 37 CFR § 1.97(b).

It is respectfully requested that the listed references be considered in the examination of this application and identified on the list of references cited on the patent issuing for this application. Applicant also requests that an initialed copy of FORM PTO/SB/08A/B be entered in the application file and returned to applicant with the next communication from the Office in accordance with MPEP § 609.

Respectfully submitted,

CHRISTIE, PARKER & HALE, LLP

D. Bruce Prout

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626/795-9900

DBP/aam

Enclosures: Form PTO/SB/08A/B, w/references

AAM PAS685929.1-\*-06/8/06 9:37 AM

# JAP20 Rec'd PCT/PTO 08 JUN 2006

FORM PTO/SB/08A/B (10-01) Substitute for PTO-1449A/B	Attorney Docket Number	57800/A400	
INFORMATION DISCLOSURE	Application Number	N <b>10/582302</b>	
	Filing Date	June 8, 2006	
STATEMENT BY APPLICANT	Applicant(s)	Shinichi Okawa, et al.	
(use as many sheets as necessary)	Group Art Unit	N/A	
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U.S. PATENT DOCUMENTS					
EXAMINER INITIALS	Cite No. <sup>1</sup>	DOCUMENT NUMBER  Number - Kind Code <sup>2</sup> (If Known)	Publication Date MM-DD-YYYY	Name of Patentee	
		2002/0151941 A1	10-17-2002	Okawa, et al.	
		5,306,144	04-26-1994	Hibst, et al.	
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		FOREIG	N PATENT DO	CUMENTS	
EXAMINER INITIALS	Cite No. <sup>1</sup>	FOREIGN PATENT DOCUMENT  Country Code <sup>3</sup> - Number <sup>4</sup> - Kind  Code <sup>5</sup> (If Known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	T <sup>c</sup> (↓)
		JP 5-337142	12-21-1993	Hibst, et al.	Corresponding U.S. 5,306,144 Above and Patent Abstract of Japan
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OTHER DOCUMENTS				
EXAMINER INITIALS	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article, title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.		
International Search Report, dated 03-15-2005, corresponding to PCT/JP2004/018672				

EXAMINER SIGNATURE		DATE CONSIDERED	

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. <sup>1</sup>Applicant's unique citation designation number (optional). <sup>2</sup>See Kinds Codes of USPTO Patent Documents at www.pto.gov or MPEP 901.4. <sup>3</sup>Enter Office that issued the document, by the two-letter code (WIPO standard ST.3). <sup>4</sup>For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. <sup>5</sup>Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. <sup>6</sup>Applicant is to place a check mark here if English Language Translation is attached.

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FORM PTO/SB/08A/B (10-01) Substitute for PTO-1449A/B	Attorney Docket Number	57800/A400
INFORMATION DISCLOSURE	Application Number	N/40/582302
	Filing Date	June 8, 2006
STATEMENT BY APPLICANT	Applicant(s)	Shinichi Okawa, et al.
(use as many sheets as necessary)	Group Art Unit	N/A
	Examiner Name	N/A

		OTHER DOCUMENTS
EXAMINER INITIALS	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article, title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.
		International Preliminary Examination Report, dated 02-09-2006, corresponding to PCT/JP2004/018672
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EXAMINER SIGNATURE	DATE CONSIDERED	
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